# MOS FIELD EFFECT TRANSISTOR 2SK3053

# SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

# DESCRIPTION

The 2SK3053 is N-Channel MOS Field Effect Transistor designed for high current switching applications in consumer instruments.

# ORDERING INFORMATION

PART NUMBER	PACKAGE
2SK3053	Isolated TO-220

# **FEATURES**

- Low On-State Resistance  $R_{DS(on)1} = 45 \text{ m}\Omega \text{ MAX.}$  (Vgs = 10 V, Ip = 13 A)  $R_{DS(on)2} = 70 \text{ m}\Omega \text{ MAX.}$  (Vgs = 4.0 V, Ip = 13 A)
- Low Ciss : Ciss = 790 pF TYP.
- Built-in Gate Protection Diode
- Isolated TO-220 package

# ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

Drain to Source Voltage	Vdss	60	V
Gate to Source Voltage	VGSS(AC)	±20	V
Gate to Source Voltage	VGSS(DC)	+20, -10	V
Drain Current (DC)	ID(DC)	±25	Α
Drain Current (Pulse) <sup>Note1</sup>	D(pulse)	±75	Α
Total Power Dissipation (Tc = 25°C)	Рт	30	W
Total Power Dissipation (T <sub>A</sub> = 25°C)	Pτ	2.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C
Single Avalanche Current Note2	las	12.5	Α
Single Avalanche Energy Note2	Eas	15.6	mJ

(Isolated TO-220)



**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty cycle  $\leq$  1 %

**2.** Starting T<sub>ch</sub> = 25 °C, V<sub>DD</sub> = 30 V, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> = 20 V  $\rightarrow$  0 V

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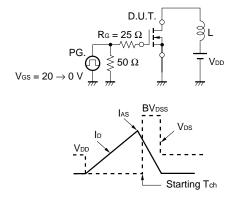
ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25 °C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, Id = 13 A		28	45	mΩ
	RDS(on)2	Vgs = 4.0 V, Id = 13 A		46	70	mΩ
Gate to Source Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.0	1.6	2.0	V
Forward Transfer Admittance	y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 13 A	8.0	16		S
Drain Leakage Current	IDSS	Vds = 60 V, Vgs = 0 V			10	μA
Gate to Source Leakage Current	lgss	$V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±10	μA
Input Capacitance	Ciss	V <sub>DS</sub> = 10 V		790		pF
Output Capacitance	Coss	V <sub>G</sub> s = 0 V		240		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		100		pF
Turn-on Delay Time	td(on)	ID = 13 A		20		ns
Rise Time	tr	Vgs = 10 V		200		ns
Turn-off Delay Time	td(off)	V <sub>DD</sub> = 30 V		65		ns
Fall Time	tr	R <sub>G</sub> = 10 Ω		95		ns
Total Gate Charge	QG	ID = 25 A		20		nC
Gate to Source Charge	QGS	V <sub>DD</sub> = 48 V		3.0		nC
Gate to Drain Charge	Qgd	V <sub>GS</sub> = 10 V		6.5		nC
Body Diode Forward Voltage	VF(S-D)	IF = 25 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 25 A, VGS = 0 V		40		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ <i>µ</i> s		45		nC

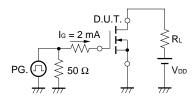
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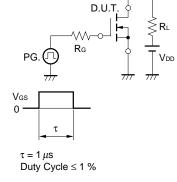
#### TEST CIRCUIT 1 AVALANCHE CAPABILITY

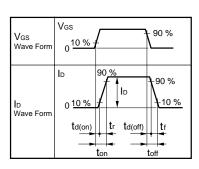
#### **TEST CIRCUIT 2 SWITCHING TIME**



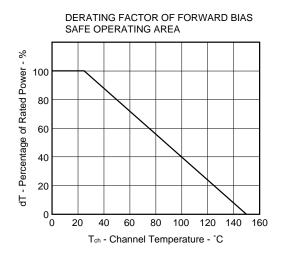
#### TEST CIRCUIT 3 GATE CHARGE

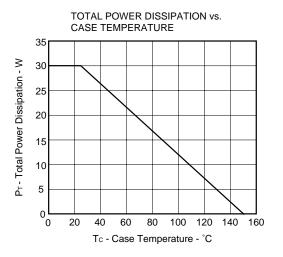




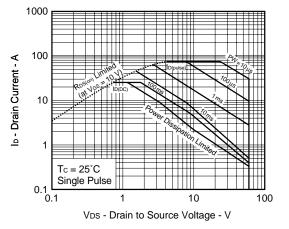


# TYPICAL CHARACTERISTICS (TA = 25 °C)

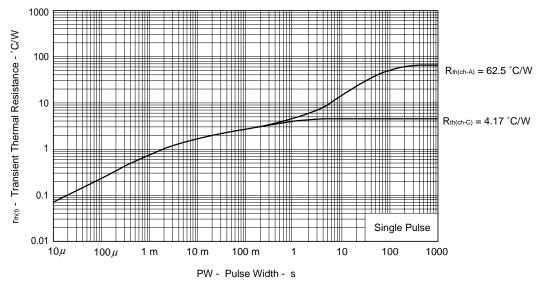




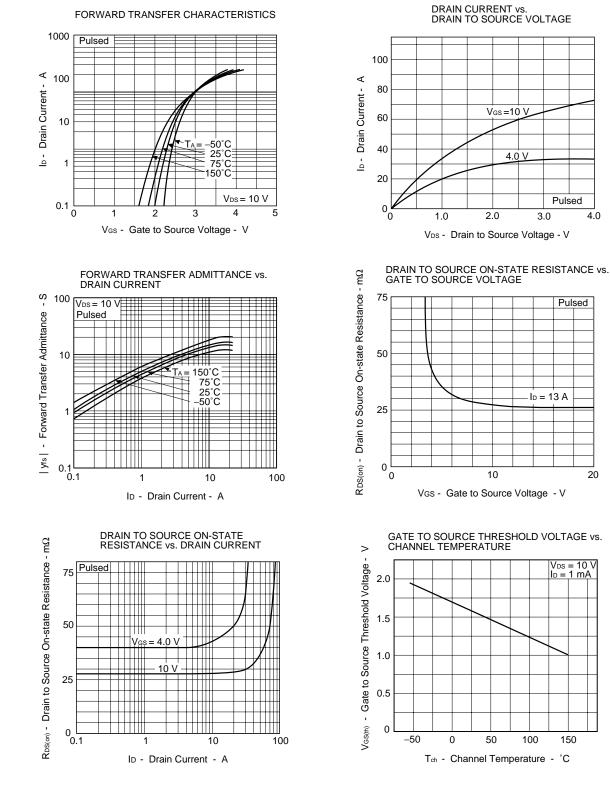
FORWARD BIAS SAFE OPERATING AREA



TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

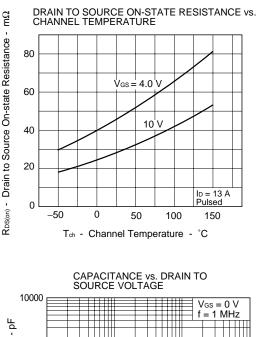


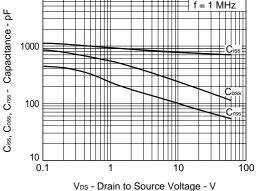
Data Sheet D12912EJ3V0DS

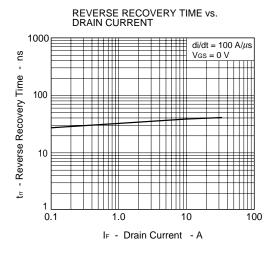


Data Sheet D12912EJ3V0DS

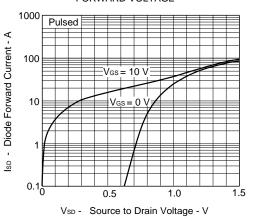
NEC



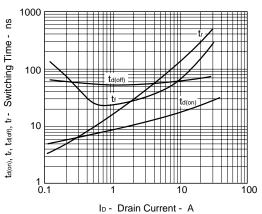




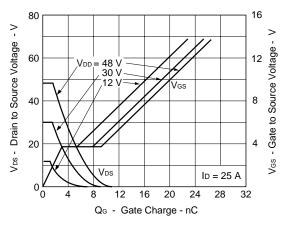
SOURCE TO DRAIN DIODE FORWARD VOLTAGE



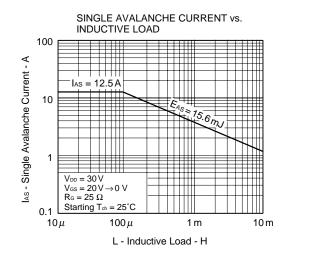
SWITCHING CHARACTERISTICS

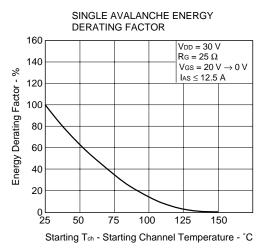






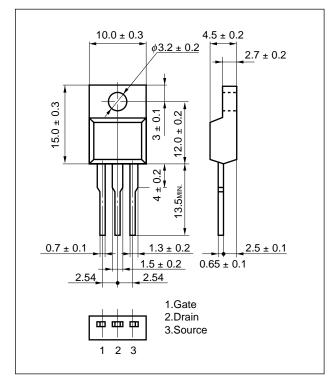
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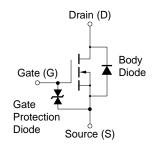


# PACKAGE DRAWING

Isolated TO-220 (MP-45F)



EQUIVALENT CIRCUIT



**Remark 1.** This product is designed for consumer application and isn't suitable for automotive application.

2. The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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